


<b>Search Notes</b> 	<b>Application/Control No.</b> 10621882	<b>Applicant(s)/Patent Under Reexamination</b> TAKIAR, HEM P.
	<b>Examiner</b> Chang, Rick K	<b>Art Unit</b> 3729

SEARCHED			
Class	Subclass	Date	Examiner
29	739,740,832,841	11/13/2006	rc
438	112,113,114,126,127,462,458,464,465,111,460		
257	797,E23.031,E23.037,E23.043,E23.07,E23.123		
	search updated	5/22/07	rc

SEARCH NOTES			
Search Notes		Date	Examiner
east search		11/13/06	rc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner